

NB4N121K

3.3V Differential In 1:21 Differential Fanout Clock Driver with HCSL level Output

Description

The NB4N121K is a Clock differential input fanout distribution 1 to 21 HCSL level differential outputs, optimized for ultra low propagation delay variation. The NB4N121K is designed with HCSL clock distribution for FBDIMM applications in mind.

Inputs can accept differential LVPECL, CML, or LVDS levels. Single-ended LVPECL, CML, LVCMOS or LVTTL levels are accepted with the proper V_{REFAC} supply (see Figures 5, 10, 11, 12, and 13). Clock input pins incorporate an internal $50\ \Omega$ on die termination resistors.

Output drive current at I_{REF} (Pin 1) for 1X load is selected by connecting to GND. To drive a 2X load, connect I_{REF} to V_{CC} . See Figure 9.

The NB4N121K specifically guarantees low output-to-output skews. Optimal design, layout, and processing minimize skew within a device and from device to device. System designers can take advantage of the NB4N121K's performance to distribute low skew clocks across the backplane or the motherboard.

Features

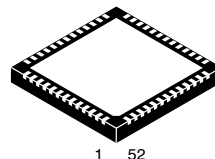
- Typical Input Clock Frequency 100, 133, 166, 200, 266, 333 and 400 MHz
- 340 ps Typical Rise and Fall Times
- 800 ps Typical Propagation Delay
- Δt_{pd} 100 ps Maximum Propagation Delay Variation Per Each Differential Pair
- <1 ps RMS Additive Clock jitter
- Operating Range: $V_{CC} = 3.0\text{ V}$ to 3.6 V with $V_{EE} = 0\text{ V}$
- Differential HCSL Output Level (700 mV Peak-to-Peak)
- Pb-Free Packages are Available*

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



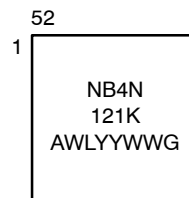
ON Semiconductor®

<http://onsemi.com>



QFN-52
MN SUFFIX
CASE 485M

MARKING DIAGRAM*



A = Assembly Site
WL = Wafer Lot
YY = Year
WW = Work Week
G = Pb-Free Package

*For additional marking information, refer to Application Note AND8002/D.

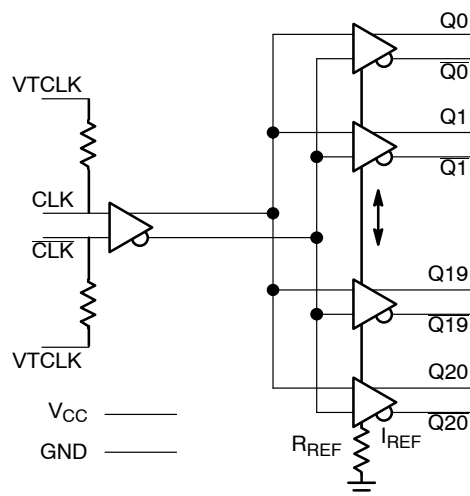


Figure 1. Pin Configuration (Top View)

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 9 of this data sheet.

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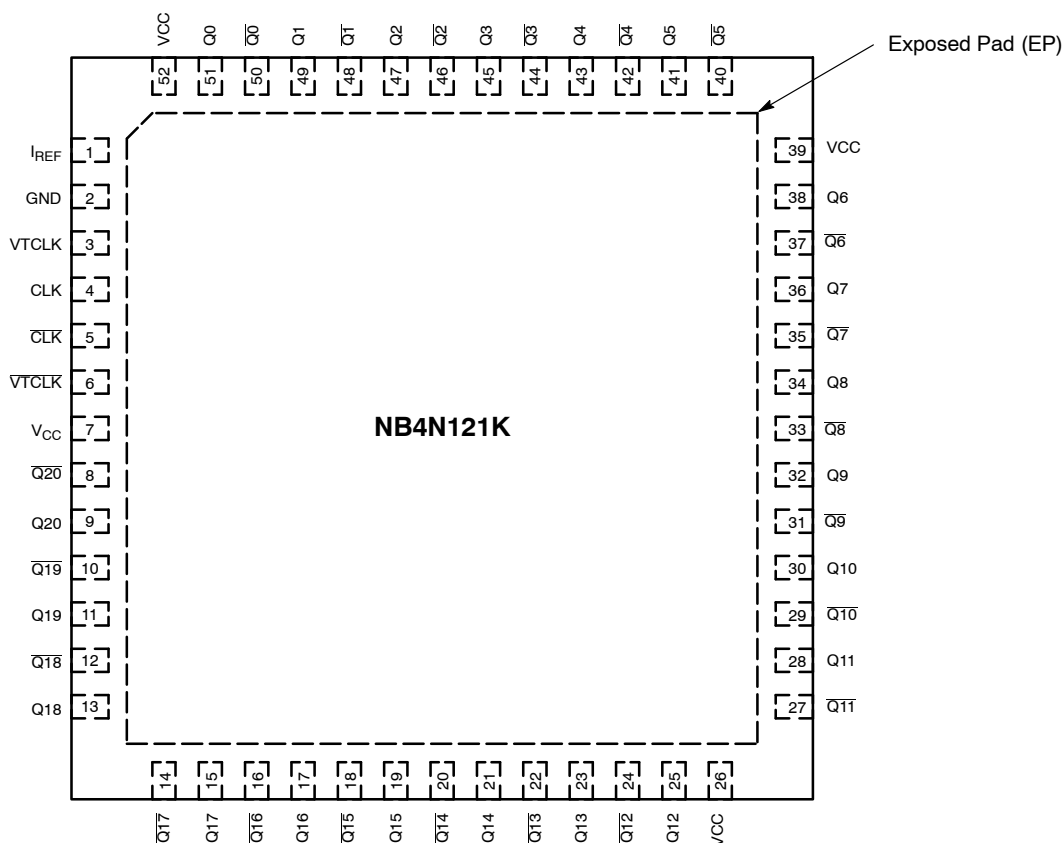


Figure 2. Pinout Configuration (Top View)

Table 1. PIN DESCRIPTION

| Pin | Name | I/O | Description |
|---|------------------|--------------|--|
| 1 | I _{REF} | Output | Output current programming pin to select load drive. For 1X configuration, connect I _{REF} to GND, or for 2X configuration, connect I _{REF} to V _{CC} (See Figure 9). |
| 2 | GND | – | Supply Ground. GND pin must be externally connected to power supply to guarantee proper operation. |
| 3, 6 | VTCLK, VTCLK | – | Internal 50 Ω Termination Resistor connection Pins. In the differential configuration when the input termination pins are connected to the common termination voltage, and if no signal is applied then the device may be susceptible to self-oscillation. |
| 4 | CLK | LVPECL Input | CLOCK Input (TRUE) |
| 5 | CLK | LVPECL Input | CLOCK Input (INVERT) |
| 7, 26, 39, 52 | V _{CC} | – | Positive Supply pins. V _{CC} pins must be externally connected to a power supply to guarantee proper operation. |
| 8, 10, 12, 14, 16, 18, 20, 22, 24, 27, 29, 31, 33, 35, 37, 40, 42, 44, 46, 48, 50 | Q[20–0] | HCSL Output | Output (INVERT) |
| 9, 11, 13, 15, 17, 19, 21, 23, 25, 28, 30, 32, 34, 36, 38, 41, 43, 45, 47, 49, 51 | Q[20–0] | HCSL Output | Output (TRUE) |
| Exposed Pad | EP | GND | Exposed Pad. The thermally exposed pad (EP) on package bottom (see case drawing) must be attached to a sufficient heat-sinking conduit for proper thermal operation. (Note 1) |

1. The exposed pad must be connected to the circuit board ground.

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Table 2. ATTRIBUTES

| Characteristic | Value |
|--|----------------------|
| Input Default State Resistors | None |
| ESD Protection Human Body Model Machine Model | >2 kV 400 V |
| Moisture Sensitivity (Note 2) QFN-52 | Level 1 |
| Flammability Rating Oxygen Index: 28 to 34 | UL 94 V-0 @ 0.125 in |
| Transistor Count | 622 |
| Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test | |

2. For additional information, see Application Note AND8003/D.

Table 3. MAXIMUM RATINGS (Note 3)

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
|---------------|---|---------------------|------------------|----------------------------------|--------------|
| V_{CC} | Positive Power Supply | GND = 0 V | | 6 | V |
| V_I | Positive Input | GND = 0 V | | $GND - 0.3 \leq V_I \leq V_{CC}$ | V |
| V_{INPP} | Differential Input Voltage CLK – CLKb | | | 1.2 | V |
| I_{OUT} | Output Current | Continuous Surge | | 50 100 | mA mA |
| T_A | Operating Temperature Range | QFN-52 | | –40 to +70 | °C |
| T_{stg} | Storage Temperature Range | | | –65 to +150 | °C |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) (Note 3) | 0 lfpm 500 lfpm | QFN-52 QFN-52 | 25 19.6 | °C/W °C/W |
| θ_{JC} | Thermal Resistance (Junction-to-Case) | 2S2P (Note 4) | QFN-52 | 21 | °C/W |
| T_{sol} | Wave Solder Pb-Free | | | 265 | °C |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

3. JEDEC standard 51–6, multilayer board – 2S2P (2 signal, 2 power).

4. JEDEC standard multilayer board – 2S2P (2 signal, 2 power) with 8 filled thermal vias under exposed pad.

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Table 4. DC CHARACTERISTICS ($V_{CC} = 3.0\text{ V to }3.6\text{ V}$, $T_A = -40^\circ\text{C to }+70^\circ\text{C}$ Note 5)

| Symbol | Characteristic | Min | Typ | Max | Unit |
|-----------|---|------|------------|-----|---------------|
| I_{GND} | GND Supply Current (All Outputs Loaded) | 70 | 98 | 120 | mA |
| I_{CC} | Power Supply Current (All Outputs Loaded) 1X 2X | | 420 780 | | mA |
| I_{IH} | Input HIGH Current CLK_x , \overline{CLK}_x | | 2.0 | 150 | μA |
| I_{IL} | Input LOW Current CLK_x , \overline{CLK}_x | -150 | -2.0 | | μA |

DIFFERENTIAL INPUT DRIVEN SINGLE-ENDED (Figures 5 and 7)

| | | | | | |
|----------|--|----------------|--|----------------|----|
| V_{th} | Input Threshold Reference Voltage Range (Note 6) | 1050 | | $V_{CC} - 150$ | mV |
| V_{IH} | Single-Ended Input HIGH Voltage | $V_{th} + 150$ | | V_{CC} | mV |
| V_{IL} | Single-Ended Input LOW Voltage | GND | | $V_{th} - 150$ | mV |

DIFFERENTIAL INPUTS DRIVEN DIFFERENTIALLY (Figures 6 and 8)

| | | | | | |
|-----------|--|------|--|---------------|----|
| V_{IHD} | Differential Input HIGH Voltage | 1200 | | V_{CC} | mV |
| V_{ILD} | Differential Input LOW Voltage | GND | | $V_{CC} - 75$ | mV |
| V_{ID} | Differential Input Voltage ($V_{IHD} - V_{ILD}$) | 75 | | 2400 | mV |
| V_{CMR} | Input Common Mode Range | 1163 | | $V_{CC} - 75$ | |

HCSL OUTPUTS (Figure 4)

| | | | | | |
|----------|---------------------|------|-----|-----|----|
| V_{OH} | Output HIGH Voltage | 600 | 740 | 900 | mV |
| V_{OL} | Output LOW Voltage | -150 | 0 | 150 | mV |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- Input parameters vary 1:1 with V_{CC} . Measurements taken with outputs in either 1X (all outputs loaded $50\ \Omega$ to GND) or 2X (all outputs loaded $25\ \Omega$ to GND) configuration, see Figure 9. For 1X configuration, connect I_{REF} to GND, or for 2X configuration, connect I_{REF} to V_{CC} .
- V_{th} is applied to the complementary input when operating in single ended mode.

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Table 5. AC CHARACTERISTICS $V_{CC} = 3.0\text{ V to }3.6\text{ V}$, $GND = 0\text{ V}$; $-40^{\circ}\text{C to }+70^{\circ}\text{C}$ (Note 7)

| Symbol | Characteristic | Min | Typ | Max | Unit |
|--|--|-----|-------------------|-----------------------|----------------------|
| V_{OUTPP} | Output Voltage Amplitude (@ $V_{INPPmin}$) $f_{in} = 133\text{ MHz}$ $f_{in} = 166\text{ MHz}$ $f_{in} = 200\text{ MHz}$ | | 725 725 725 | 900 900 900 | mV |
| t_{PLH} , t_{PHL} | Propagation Delay to (See Figure 3) CLK/\overline{CLK} to Qx/\overline{Qx} | 550 | 800 | 950 | ps |
| Δt_{PLH} , Δt_{PHL} | Propagation Delay Variations Variation Per Each Diff Pair CLK/\overline{CLK} to Qx/\overline{Qx} (Note 8) (See Figure 3) | | | 100 | ps |
| t_{SKEW} | Duty Cycle Skew (Note 9) Within-Device Skew, 1X Mode Only (Note 10) Within-Device Skew, 2X Mode (Note 10) Device-to-Device Skew (Note 10) | | | 20 50 80 150 | ps ps ps ps |
| t_{JITTER} | RMS Random Clock Jitter (Note 11) $f_{in} = 133\text{ MHz}$ $f_{in} = 166\text{ MHz}$ $f_{in} = 200\text{ MHz}$ | | | 1 | ps |
| V_{INPP} | Input Voltage Swing/Sensitivity (Differential Configuration) | 150 | | 1200 | mV |
| V_{cross} | Absolute Crossing Magnitude Voltage | 250 | | 550 | mV |
| ΔV_{cross} | Variation in Magnitude of V_{cross} | | | 150 | mV |
| t_r , t_f | Absolute Magnitude in Output Risetime and Falltime (From 175 mV to 525 mV) Qx , \overline{Qx} | 175 | 340 | 700 | ps |
| Δt_r , Δt_f | Variation in Magnitude of Risetime and Falltime (Single-Ended) (See Figure 4) Qx , \overline{Qx} 1X 2X | | | 125 150 | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

7. Measured by forcing V_{INPP} (MIN) from a 50% duty cycle clock source. Measurements taken with outputs in either 1X (all outputs loaded 50 Ω to GND) or 2X (all outputs loaded 25 Ω to GND) configuration, see Figure 9. For 1X configuration, connect I_{REF} to GND, or for 2X configuration, connect I_{REF} to V_{CC} . Typical gain is 20 dB.
8. Measured from the input pair crosspoint to each single output pair crosspoint across temp and voltage ranges.
9. Duty cycle skew is measured between differential outputs using the deviations of the sum of $Tpw-$ and $Tpw+$.
10. Skew is measured between outputs under identical transition @ 133 MHz.
11. Additive RMS jitter with 50% duty cycle clock signal using phase noise integrated from 12 KHz to 33 MHz

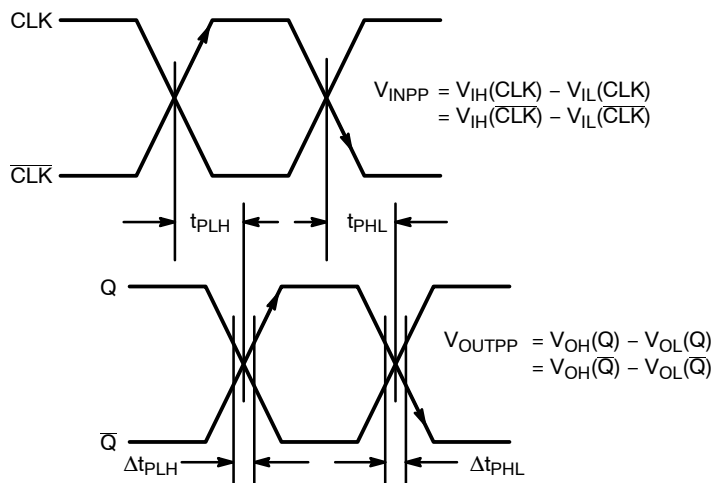


Figure 3. AC Reference Measurement

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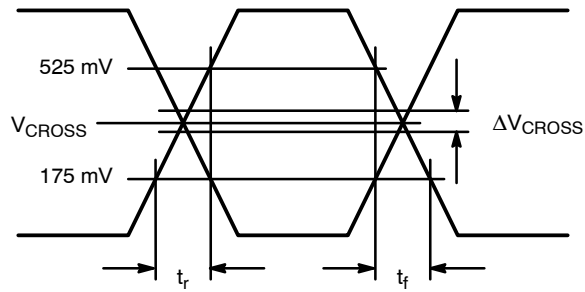


Figure 4. HCSL Output Parameter Characteristics

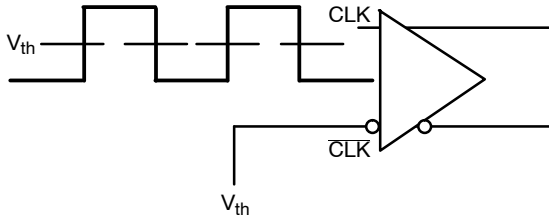


Figure 5. Differential Input Driven Single-Ended ($V_{th} = V_{REFAC}$)

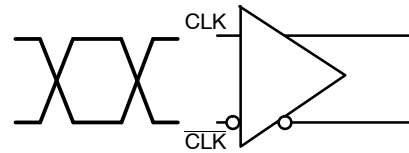


Figure 6. Differential Inputs Driven Differentially

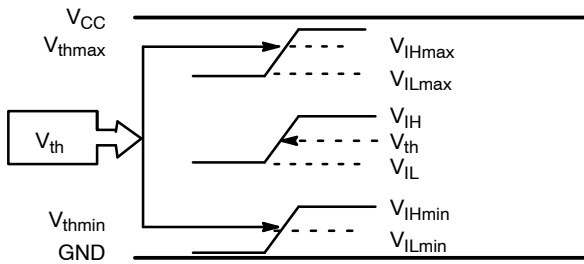


Figure 7. V_{th} Diagram

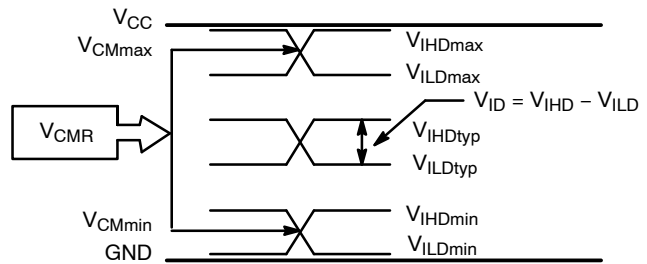


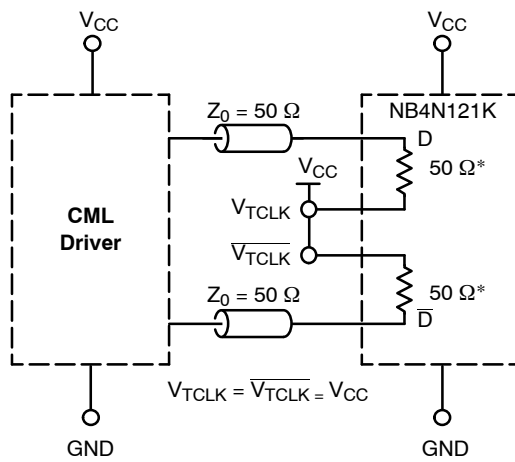
Figure 8. V_{CMR} Diagram

For 1X configuration, connect I_{REF} pin to GND or for 2X configuration, connect I_{REF} pin to V_{CC} . To adjust load drive for 1X configuration, use R_{REF} from $0\ \Omega$ to $20\ k\Omega$. To adjust 2X load, use $20\ k\Omega$ to $200\ k\Omega$.

| Test Condition | R_{S1} | R_{S2} | R_{L1} | R_{L2} | $CL1$ | $CL2$ | $CL3$ | $CL4$ |
|---------------------------------|-------------|-------------|--------------|--------------|---------|---------|---------|---------|
| Minimizing Ringing | $0\ \Omega$ | $0\ \Omega$ | $50\ \Omega$ | $50\ \Omega$ | $2\ pF$ | $2\ pF$ | $2\ pF$ | $2\ pF$ |
| Receiver Input Capacitance Only | $0\ \Omega$ | $0\ \Omega$ | $0\ \Omega$ | $0\ \Omega$ | $2\ pF$ | $2\ pF$ | $2\ pF$ | $2\ pF$ |

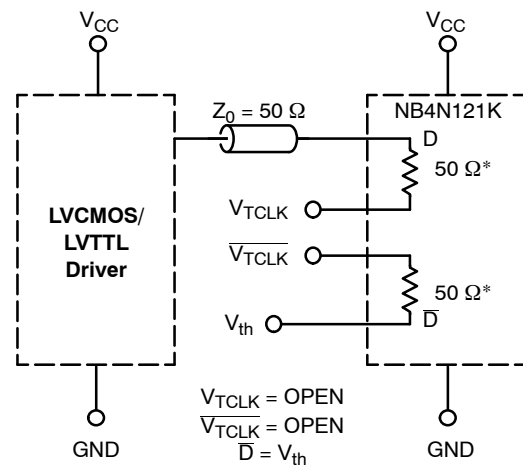
The schematic diagram shows an LVPECL Driver connected to a 3.3 V supply and ground. The driver's output is connected to the input of an NB4N121K receiver through a series resistor $Z_0 = 50\ \Omega$. The receiver is also connected to a 3.3 V supply and ground. The receiver's input is connected to the output of the driver through a series resistor $Z_0 = 50\ \Omega$. The receiver's input is also connected to ground through a $50\ \Omega$ resistor. The receiver's output is connected to ground through a $50\ \Omega$ resistor. The receiver's input is labeled D and the output is labeled \overline{D} . The receiver's input is also connected to 3.3 V through a $50\ \Omega$ resistor. The receiver's output is connected to 3.3 V through a $50\ \Omega$ resistor. The receiver's input is connected to the output of the driver through a series resistor $Z_0 = 50\ \Omega$. The receiver's input is also connected to ground through a $50\ \Omega$ resistor. The receiver's output is connected to ground through a $50\ \Omega$ resistor. The receiver's input is labeled D and the output is labeled \overline{D} . The receiver's input is also connected to 3.3 V through a $50\ \Omega$ resistor. The receiver's output is connected to 3.3 V through a $50\ \Omega$ resistor.

Figure 11. LVDS Interface

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*RTIN, Internal Input Termination Resistor

Figure 12. Standard 50 Ω Load CML Interface



*RTIN, Internal Input Termination Resistor

Figure 13. LVCMOS/LVTTL Interface

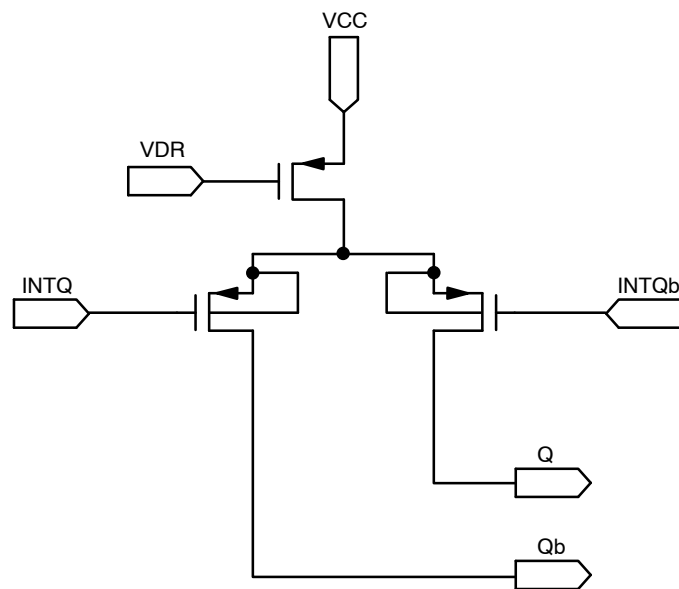


Figure 14. HCSL Output Structure

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ORDERING INFORMATION

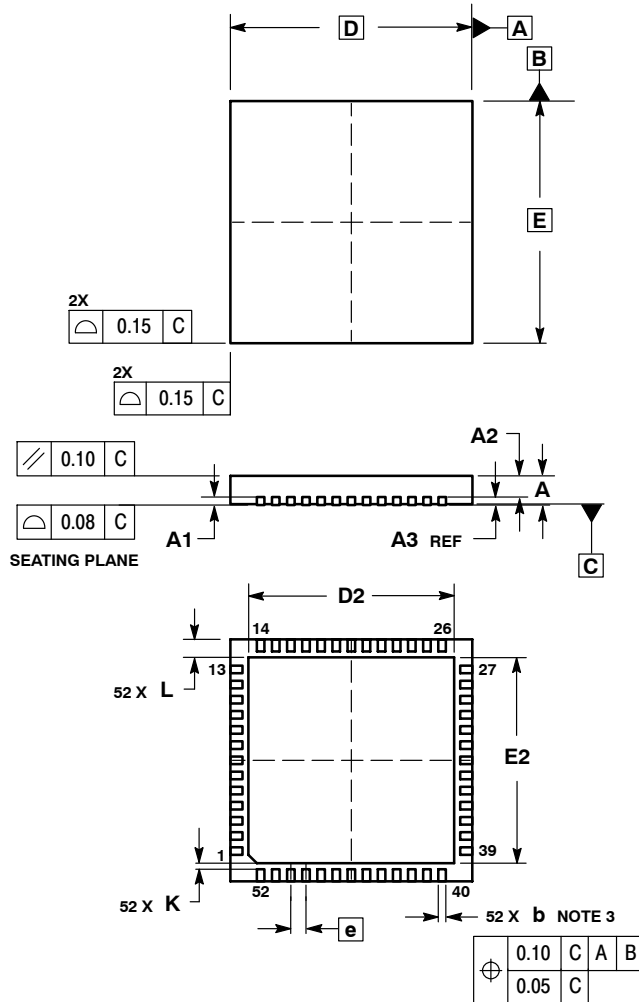
| Device | Package | Shipping† |
|---------------|---------------------|--------------------|
| NB4N121KMN | QFN-52 | 260 Units / Tray |
| NB4N121KMNG | QFN-52 (Pb-Free) | 260 Units / Tray |
| NB4N121KMNR2 | QFN-52 | 2000 / Tape & Reel |
| NB4N121KMNR2G | QFN-52 (Pb-Free) | 2000 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

NB4N121K


PACKAGE DIMENSIONS

52 PIN QFN 8x8
CASE 485M-01
ISSUE A



- NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS
 3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL.
 4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

| DIM | MILLIMETERS | |
|-----|-------------|------|
| | MIN | MAX |
| A | 0.80 | 1.00 |
| A1 | 0.00 | 0.05 |
| A2 | 0.60 | 0.80 |
| A3 | 0.20 | REF |
| b | 0.18 | 0.30 |
| D | 8.00 | BSC |
| D2 | 6.50 | 6.80 |
| E | 8.00 | BSC |
| E2 | 6.50 | 6.80 |
| e | 0.50 | BSC |
| K | 0.20 | --- |
| L | 0.30 | 0.50 |

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